



SEMiX® 3p

Trench IGBT Modules

SEMiX603GAR12E4p

Features

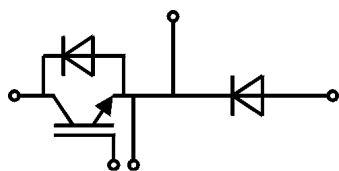
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability
- Press-fit pins as auxiliary contacts
- Thermally optimized ceramic
- UL recognized, file no. E63532

Typical Applications*

- AC inverter drives
- UPS
- Renewable energy systems

Remarks

- Product reliability results are valid for $T_j = 150^\circ\text{C}$
- V_{isol} between temperature sensor and power section is only 2500V
- For storage and case temperature with TIM see document "TP(*) SEMiX 3p"



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Absolute Maximum Ratings

Symbol	Conditions	Values	Unit
IGBT			
V_{CES}	$T_j = 25^\circ\text{C}$	1200	V
I_C	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	1110
		$T_c = 80^\circ\text{C}$	853
I_{Cnom}		600	A
I_{CRM}	$I_{CRM} = 3 \times I_{Cnom}$	1800	A
V_{GES}		-20 ... 20	V
t_{psc}	$V_{CC} = 800\text{ V}$ $V_{GE} \leq 15\text{ V}$ $V_{CES} \leq 1200\text{ V}$	$T_j = 150^\circ\text{C}$	10
T_j		-40 ... 175	$^\circ\text{C}$
Inverse diode			
V_{RRM}	$T_j = 25^\circ\text{C}$	1200	V
I_F	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	856
		$T_c = 80^\circ\text{C}$	640
I_{Fnom}		600	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$	1200	A
I_{FSM}	$t_p = 10\text{ ms, sin } 180^\circ, T_j = 25^\circ\text{C}$	3456	A
T_j		-40 ... 175	$^\circ\text{C}$
Freewheeling diode			
V_{RRM}	$T_j = 25^\circ\text{C}$	1200	V
I_F	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	856
		$T_c = 80^\circ\text{C}$	640
I_{Fnom}		600	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$	1200	A
I_{FSM}	$t_p = 10\text{ ms, sin } 180^\circ, T_j = 25^\circ\text{C}$	3456	A
T_j		-40 ... 175	$^\circ\text{C}$
Module			
$I_{t(RMS)}$		600	A
T_{stg}	module without TIM	-40 ... 125	$^\circ\text{C}$
V_{isol}	AC sinus 50Hz, $t = 1\text{ min}$	4000	V

Characteristics

Symbol	Conditions	min.	typ.	max.	Unit
IGBT					
$V_{CE(sat)}$	$I_C = 600\text{ A}$ $V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$	1.80	2.05	V
		$T_j = 150^\circ\text{C}$	2.03	2.30	V
V_{CE0}	chipelevel	$T_j = 25^\circ\text{C}$	0.87	1.01	V
		$T_j = 150^\circ\text{C}$	0.77	0.9	V
r_{CE}	$V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$	1.55	1.73	m Ω
		$T_j = 150^\circ\text{C}$	2.1	2.3	m Ω
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 22.2\text{ mA}$	5.3	5.8	6.3	V
I_{CES}	$V_{GE} = 0\text{ V}, V_{CE} = 1200\text{ V}, T_j = 25^\circ\text{C}$			5	mA
C_{ies}	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	37.5		nF
C_{oes}		$f = 1\text{ MHz}$	2.31		nF
C_{res}		$f = 1\text{ MHz}$	2.04		nF
Q_G	$V_{GE} = -8\text{ V} \dots +15\text{ V}$		3450		nC
R_{Gint}	$T_j = 25^\circ\text{C}$		1.2		Ω



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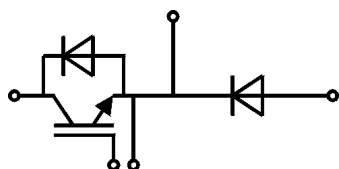
Typical Applications*

- AC inverter drives
- UPS
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Remarks

- Product reliability results are valid for $T_j=150^\circ\text{C}$
- V_{isol} between temperature sensor and power section is only 2500V
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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
IGBT						
t _{d(on)}	V _{CC} = 600 V	T _j = 150 °C		160		ns
t _r	I _C = 600 A	T _j = 150 °C		80		ns
E _{on}	V _{GE} = +15/-15 V	T _j = 150 °C		64		mJ
t _{d(off)}	R _{G on} = 1.5 Ω	T _j = 150 °C		540		ns
t _f	R _{G off} = 1.5 Ω	T _j = 150 °C		130		ns
E _{off}	di/dt _{on} = 7270 A/μs du/dt = 3500 V/μs L _s = 21 nH	T _j = 150 °C		76		mJ
R _{th(j-c)}	per IGBT				0.037	K/W
R _{th(c-s)}	per IGBT (λ _{grease} =0.81 W/(m*K))			0.035		K/W
R _{th(c-s)}	per IGBT, pre-applied phase change material			0.025		K/W
Inverse diode						
V _F = V _{EC}	I _F = 600 A	T _j = 25 °C		2.08	2.44	V
	V _{GE} = 0 V chiplevel	T _j = 150 °C		2.08	2.34	V
V _{F0}	chiplevel	T _j = 25 °C		1.39	1.59	V
		T _j = 150 °C		1.08	1.18	V
r _F	chiplevel	T _j = 25 °C		1.16	1.42	mΩ
		T _j = 150 °C		1.67	1.93	mΩ
I _{RRM}	I _F = 600 A	T _j = 150 °C		490		A
Q _{rr}	di/dt _{off} = 7170 A/μs	T _j = 150 °C		93		μC
E _{rr}	V _{GE} = -15 V V _{CC} = 600 V	T _j = 150 °C		32		mJ
R _{th(j-c)}	per diode				0.065	K/W
R _{th(c-s)}	per diode (λ _{grease} =0.81 W/(m*K))			0.039		K/W
R _{th(c-s)}	per diode, pre-applied phase change material			0.031		K/W
Freewheeling diode						
V _F = V _{EC}	I _F = 600 A	T _j = 25 °C		2.08	2.44	V
	V _{GE} = 0 V chiplevel	T _j = 150 °C		2.08	2.34	V
V _{F0}	chiplevel	T _j = 25 °C		1.39	1.59	V
		T _j = 150 °C		1.08	1.18	V
r _F	chiplevel	T _j = 25 °C		1.16	1.42	mΩ
		T _j = 150 °C		1.67	1.93	mΩ
I _{RRM}	I _F = 600 A	T _j = 150 °C		490		A
Q _{rr}	di/dt _{off} = 7170 A/μs	T _j = 150 °C		93		μC
E _{rr}	V _{GE} = -15 V V _{CC} = 600 V	T _j = 150 °C		32		mJ
R _{th(j-c)}	per diode				0.065	K/W
R _{th(c-s)}	per diode (λ _{grease} =0.81 W/(m*K))			0.039		K/W
R _{th(c-s)}	per diode, pre-applied phase change material			0.031		K/W



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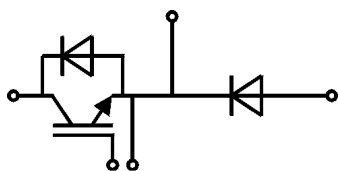
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Characteristics

Symbol	Conditions	min.	typ.	max.	Unit
Module					
L_{CE}			20		nH
$R_{CC'+EE'}$	measured per switch		1.2		mΩ
	$T_C = 125^\circ\text{C}$		1.65		mΩ
$R_{th(c-s)1}$	calculated without thermal coupling		0.009		K/W
$R_{th(c-s)2}$	including thermal coupling, T_s underneath module ($\lambda_{grease}=0.81\text{ W/(m}^2\text{K)}$)		0.014		K/W
$R_{th(c-s)2}$	including thermal coupling, T_s underneath module, pre-applied phase change material		0.011		K/W
M_s	to heat sink (M5)	3		6	Nm
M_t					
	to terminals (M6)	3		6	Nm
					Nm
w				350	g
Temperature Sensor					
R_{100}	$T_C=100^\circ\text{C}$ ($R_{25}=5\text{ k}\Omega$)		$493 \pm 5\%$		Ω
$B_{100/125}$	$R_{(T)}=R_{100}\exp[B_{100/125}(1/T-1/T_{100})]$; $T[K]$		$3550 \pm 2\%$		K



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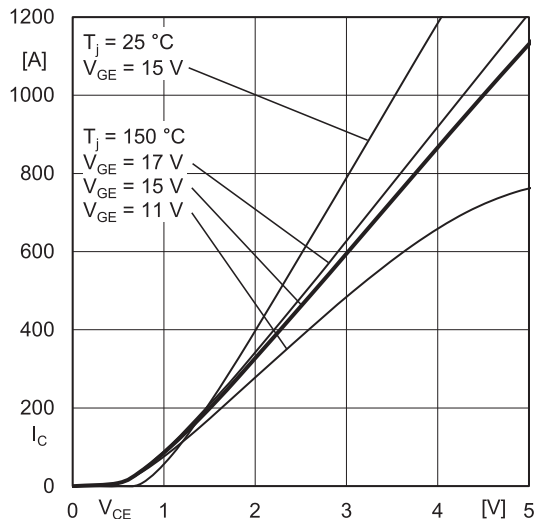


Fig. 1: Typ. output characteristic, inclusive $R_{CC} + EE'$

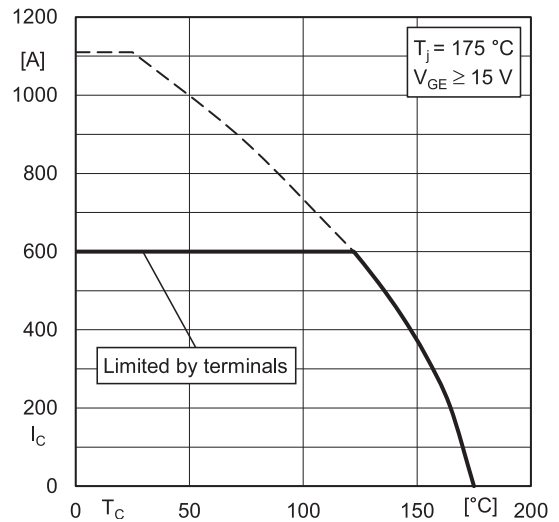


Fig. 2: Rated current vs. temperature $I_C = f(T_C)$

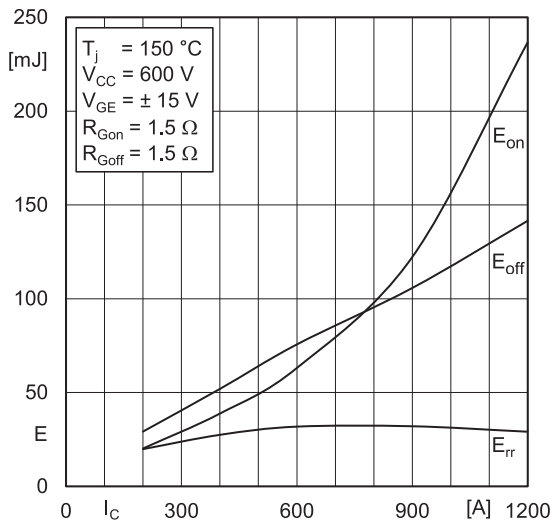


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

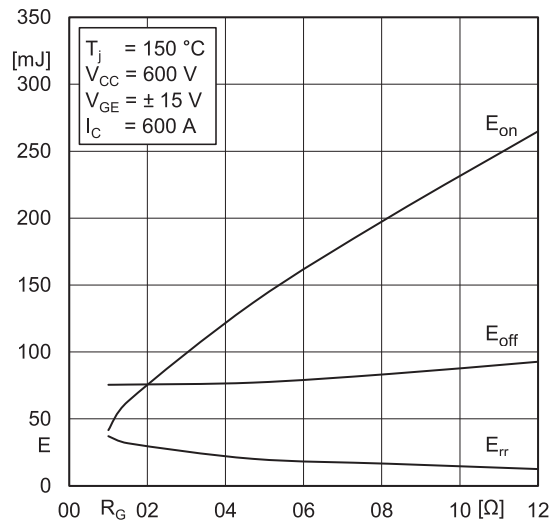


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

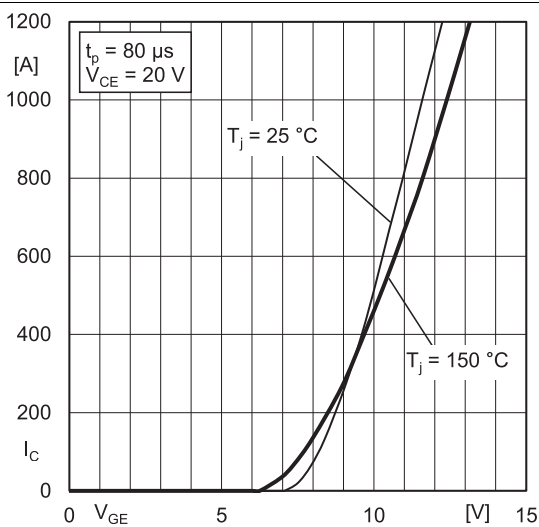


Fig. 5: Typ. transfer characteristic

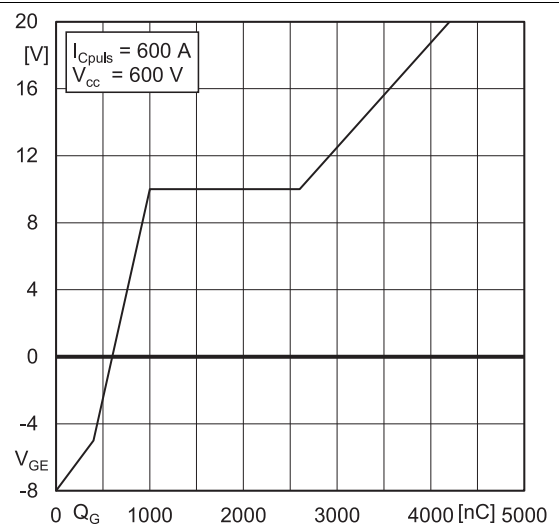


Fig. 6: Typ. gate charge characteristic

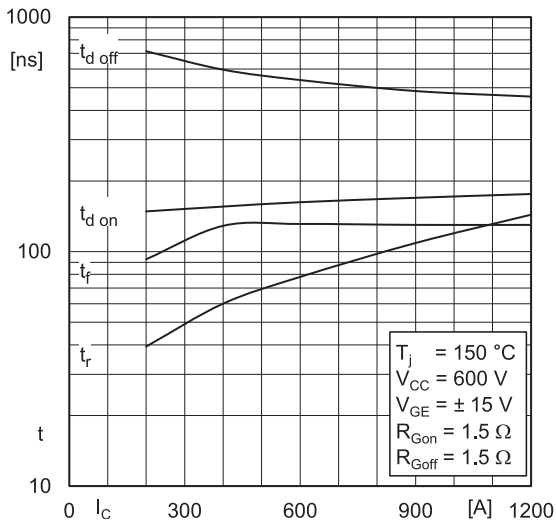


Fig. 7: Typ. switching times vs. I_C

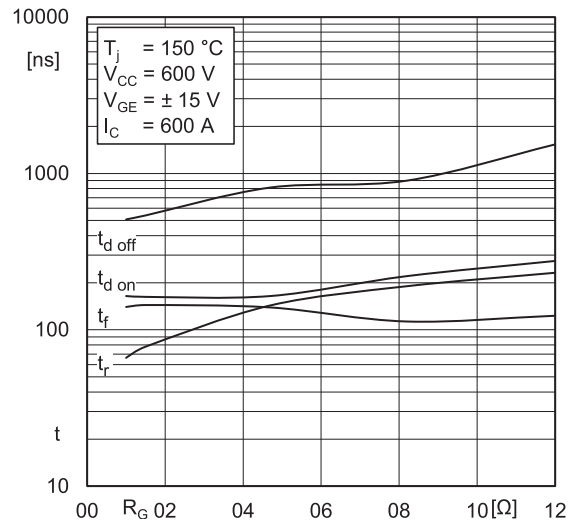


Fig. 8: Typ. switching times vs. gate resistor R_G

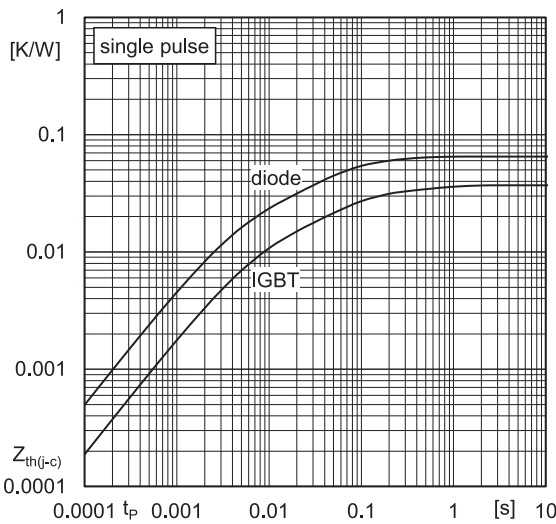


Fig. 9: Transient thermal impedance

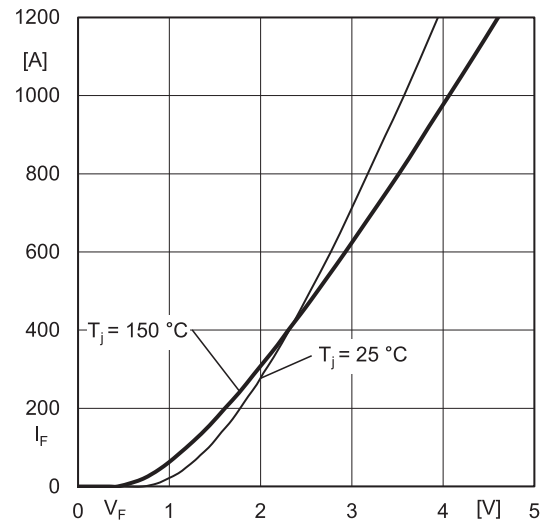


Fig. 10: Typ. CAL diode forward charact., incl. $R_{CC'+EE'}$

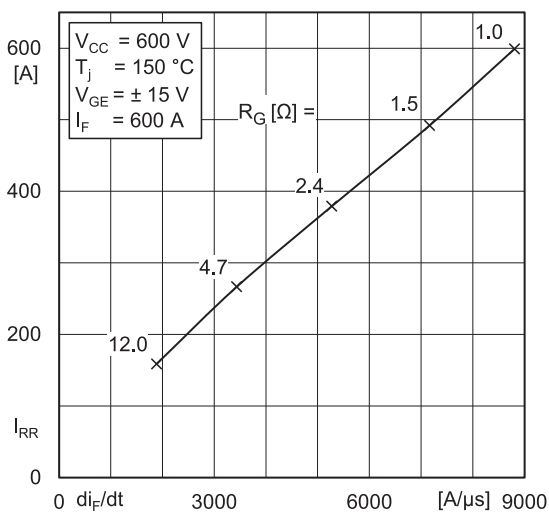


Fig. 11: Typ. CAL diode peak reverse recovery current

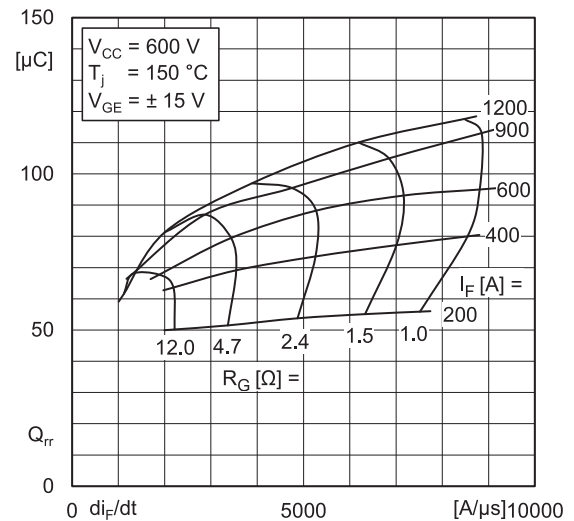
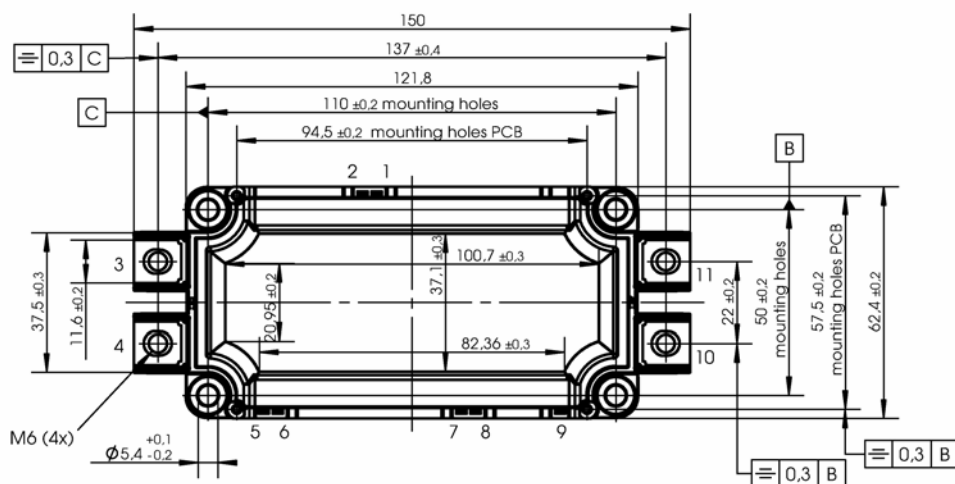
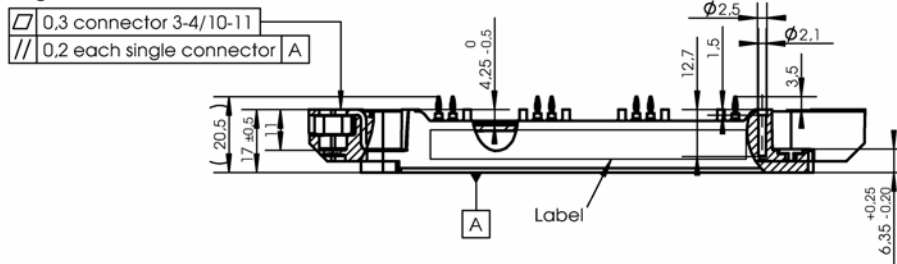
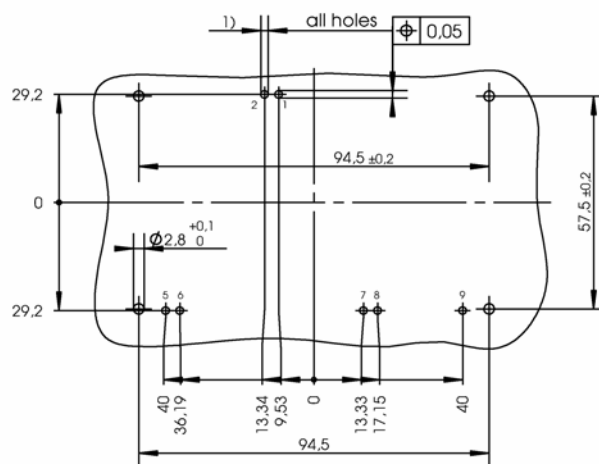


Fig. 12: Typ. CAL diode recovery charge

Package outline

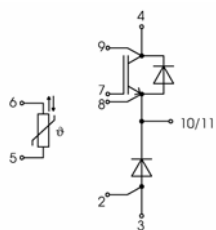


PCB drillhole pattern



Dimensions valid in mounted status

1) PCB hole specification see Mounting Instructions SEMiX press-fit



pinout

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

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